

Shenzhen CTA Testing Technology Co., Ltd.

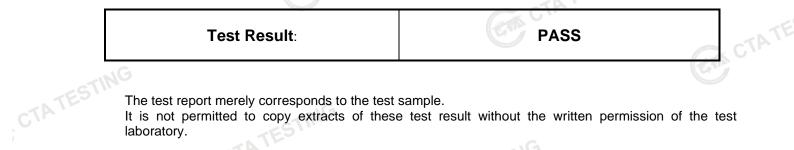
Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	FCC PART 15.247	
	CT CCT AKT 13.247	TESTING
Report Reference No	: CTA24041700501	CTA TESTING
FCC ID	:: 2A8ZB-G232	
Compiled by	noturo) :	ao Jungtura 10200
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Supervised by	- 1G	Theman
	nature): Project Engineer Zoey Cao	UIA
Approved by		approved
(position+printed name+sig	nature): RF Manager Eric Wang	
Date of issue	: May. 13, 2024	STIN
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Address		i Industrial Park, Qiaotou Community,
Auu 655	Fuhai Street, Baoʻan District, S	Shenzhen, China
Applicant's name	Shenzhen Weiwo Intelligent	Electronics Co., Ltd
Address	Floor 2, building A7, No. 416, X	Xuegang North Road, Qinghu
	community, Longhua street, Lo	onghua District, Shenzhen, China
Test specification		
-		
Standard		TATESTING
Standard Shenzhen CTA Testing Te This publication may be rep Shenzhen CTA Testing Tec material. Shenzhen CTA Te	chnology Co., Ltd. All rights reserved roduced in whole or in part for non-comn hnology Co., Ltd. is acknowledged as co sting Technology Co., Ltd. takes no res	nercial purposes as long as the opyright owner and source of the ponsibility for and will not assume
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Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

	CTATESTING		TEST REPORT
	CTA		TESTING
	Equipment under Test	:	4G smartwatch G232
	Model /Type	:	G232
ESTIN	Listed Models	E	G130, G131, G132, G133, G134, G135, G136, G137, G138, G139, G140, G141, G142, G143, G144, G145, G146, G147, G148, G149, G150, G230, G231, G233, G234, G235, G236, G237, G238, G239, G240, G241, G242, G243, G245, G246, G247, G248, G249, G250, G251, G252, G253, G254, G255, G256, G257, G258, G259, G260
	Applicant	:	Shenzhen Weiwo Intelligent Electronics Co., Ltd
	Address	:	Floor 2, building A7, No. 416, Xuegang North Road, Qinghu community, Longhua street, Longhua District, Shenzhen, China
	Manufacturer	:	Shenzhen Weiwo Intelligent Electronics Co., Ltd
G	Address	-	Floor 2, building A7, No. 416, Xuegang North Road, Qinghu community, Longhua street, Longhua District, Shenzhen, China



The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test CTATESTING laboratory.

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TEST STANDARDS 1

The tests were performed according to following standards:

FCC Rules Part 15.247: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. ANSI C63.10-2013: American National Standard for Testing Unlicensed Wireless Devices CTATE KDB558074 D01 V05r02: Guidance for Performing Compliance Measurements on Digital Transmission

Systems (DTS) Operating Under §15.247 CTATESTING

2 SUMMARY

2.1 **General Remarks**

CTATES			
2.1 General Remarks			
Date of receipt of test sample		Apr. 01, 2024	
Testing commenced on		Apr. 01, 2024	
Testing concluded on	:	May. 13, 2024	

2.2 Product Description*

2.2 Product Descri	iption*
Product Description:	4G smartwatch
Model/Type reference:	G232
Power supply:	DC 3.85V From battery and DC 5.0V From external circuit
Adapter information (Auxiliary test supplied by test Lab):	Model: EP-TA20CBC Input: AC 100-240V 50/60Hz Output: DC 5V 2A
Hardware version:	C16_V1.5
Software version:	G232_32_EN_V2.5_20240403
Testing sample ID:	CTA240417005-1# (Engineer sample) CTA240417005-2# (Normal sample)
Bluetooth BLE	
Supported type:	Bluetooth low Energy
Modulation:	GFSK
Operation frequency:	2402MHz to 2480MHz
Channel number:	40
Channel separation:	2 MHz
Antenna type:	PIFA antenna
Antenna gain:	0.68 dBi

2.3 Equipment Under Test

Power supply system utilised

2.3 Equipment Under Test Power supply system utilised				C/L	
Power supply voltage	:	0	230V / 50 Hz) 120V / 60Hz	
	10	0	12 V DC) 24 V DC	
-sTI	4	•	Other (specified in blank below	v)	

DC 3.85V From battery and DC 5.0V From external circuit

2.4 Short description of the Equipment under Test (EUT)

This is a 4G smartwatch. For more details, refer to the user's manual of the EUT.

2.5 EUT operation mode

The Applicant provides command "*#*#3646633#*#*" access (Engineer mode) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing. There are 40 channels provided to the EUT and Channel 00/19/39 were selected to test.

Channel	Frequency (MHz)
00	2402
01	2404
02	2406
19	2440
ESTIN	÷
37	2476
38	2478
39	2480

2.6 Block Diagram of Test Setup

EUT

~	DC 5.0V from adapter
3	

Related Submittal(s) / Grant (s) 2.7

This submittal(s) (test report) is intended for filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

2.8 **Modifications**

No modifications were implemented to meet testing criteria. GA CTATESTING

3 TEST ENVIRONMENT

Address of the test laboratory 3.1

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Environmental conditions

During the measurement the environmental conditions were within the listed ranges: Radiated Emission:

Temperature:	23 ° C
	TES
Humidity:	44 %
Atmospheric pressure:	950-1050mbar

AC Main Conducted testing.

Temperature:	24 ° C			
-1G				
Humidity:	47 %			
	C.			
Atmospheric pressure:	950-1050mbar			

	Autospheric pressure.	930-1030mbai	
С	onducted testing:	TES	TING
	Temperature:	24 ° C	TESI
	Constant of the second second		(A)
	Humidity:	46 %	
	Atmospheric pressure:	950-1050mbar]

	Test Specification clause	Test case	Test Mode	Test Channel		ecorded Report	Test result
	§15.247(e)	Power spectral density	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	BLE 1Mpbs	 ☑ Lowest ☑ Middle ☑ Highest 	complies
	§15.247(a)(2)	Spectrum bandwidth – 6 dB bandwidth	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	BLE 1Mpbs	 ☑ Lowest ☑ Middle ☑ Highest 	complies
	§15.247(b)(3)	Maximum output Peak power	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	complies
CTATE	§15.247(d)	Band edge compliance conducted	BLE 1Mpbs	⊠ Lowest ⊠ Highest	BLE 1Mpbs	⊠ Lowest ⊠ Highest	complies
, C.	§15.205	Band edge compliance radiated	BLE 1Mpbs	⊠ Lowest ⊠ Highest	BLE 1Mpbs	⊠ Lowest ⊠ Highest	complies
	§15.247(d)	TX spurious emissions conducted	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	BLE 1Mpbs	⊠ Lowest ⊠ Middle ⊠ Highest	complies
	§15.247(d)	TX spurious emissions radiated	BLE 1Mpbs	Lowest Middle	BLE 1Mpbs	 ☑ Lowest ☑ Middle ☑ Highest 	complies
G	§15.209(a)	TX spurious Emissions radiated Below 1GHz	BLE 1Mpbs	-/-	BLE 1Mpbs	-/-	complies
	§15.107(a) §15.207	Conducted Emissions < 30 MHz	BLE 1Mpbs	1NG -/-	BLE 1Mpbs	-/-	complies

3.4 Summary of measurement results

Remark:

1. The measurement uncertainty is not included in the test result.

We tested all test mode and recorded worst case in report 2.

Statement of the measurement uncertainty 3.5

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. TESTING Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd.

u.	e best measurement capability for Shenzhen CTA resting rechnology Co., Lic							
	Test	Range	Measurement Uncertainty	Notes				
	Radiated Emission	9KHz~30MHz	3.02 dB	(1)				
-	Radiated Emission	30~1000MHz	4.06 dB	(1)				
	Radiated Emission	1~18GHz	5.14 dB 🔪	(1)				
	Radiated Emission	18-40GHz	5.38 dB	(1)				
	Conducted Disturbance	0.15~30MHz	2.14 dB	(1)				
	Output Peak power	30MHz~18GHz	0.55 dB	(1)				
P	Power spectral density	-ING	0.57 dB	(1)				
	Spectrum bandwidth		1.1%	(1)				
	Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)				
	Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)				
	Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)				

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6 Equipments Used during the Test

			TESI			
	Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
	LISN	R&S	ENV216	CTA-308	2023/08/02	2024/08/01
	LISN	R&S	ENV216	CTA-314	2023/08/02	2024/08/01
ď	EMI Test Receiver	R&S	ESPI	CTA-307	2023/08/02	2024/08/01
EP	EMI Test Receiver	R&S	ESCI	CTA-306	2023/08/02	2024/08/01
	Spectrum Analyzer	Agilent	N9020A	CTA-301	2023/08/02	2024/08/01
	Spectrum Analyzer	R&S	FSP	CTA-337	2023/08/02	2024/08/01
	Vector Signal generator	Agilent	N5182A	CTA-305	2023/08/02	2024/08/01
	Analog Signal Generator	R&S	SML03	CTA-304	2023/08/02	2024/08/01
	WIDEBAND RADIO COMMUNICATION TESTER	G CMW500	R&S	CTA-302	2023/08/02	2024/08/01
Sile	Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2023/08/02	2024/08/01
	Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2024/10/16
	Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2024/10/12
	Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2024/10/16
	Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2021/08/07	2024/08/06
37	Amplifier	Schwarzbeck	BBV 9745	CTA-312	2023/08/02	2024/08/01
5	Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2023/08/02	2024/08/01
	Directional coupler	NARDA	4226-10	CTA-303	2023/08/02	2024/08/01
	High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2023/08/02	2024/08/01
	High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2023/08/02	2024/08/01
	Automated filter bank	Tonscend	JS0806-F	CTA-404	2023/08/02	2024/08/01
	Power Sensor	GAgilent	U2021XA	CTA-405	2023/08/02	2024/08/01
	Amplifier	Schwarzbeck	BBV9719	CTA-406	2023/08/02	2024/08/01
	Amplifier	Schwarzbeck	BBV9719			2023/08/02

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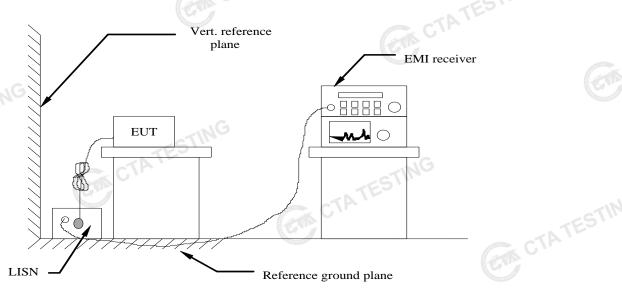
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Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date
EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A
RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A
STING	CTATESTING				Guy
	TESI				

TEST CONDITIONS AND RESULTS 4

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.

2 Support equipment, if needed, was placed as per ANSI C63.10-2013

3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013

4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.

5 All support equipments received AC power from a second LISN, if any.

6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT.The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.

7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

8 During the above scans, the emissions were maximized by cable manipulation.

AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following :

	Limit (dBuV)						
Frequency range (MHz)	Quasi-peak	Average					
0.15-0.5	66 to 56*	56 to 46*					
0.5-5	56	46					
5-30	60	50					

Decreases with the logarithm of the frequency.

TEST RESULTS

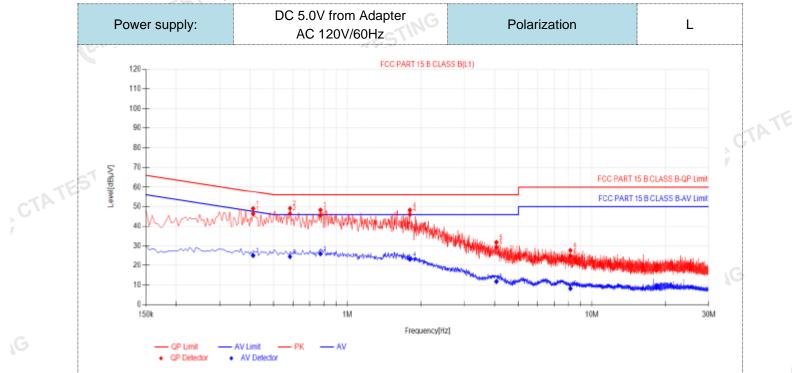
Remark:

1. BLE 1Mpbs was tested at Low, Middle, and High channel; only the worst result of BLE 1Mpbs High channel was reported as below:

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TATE

2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:

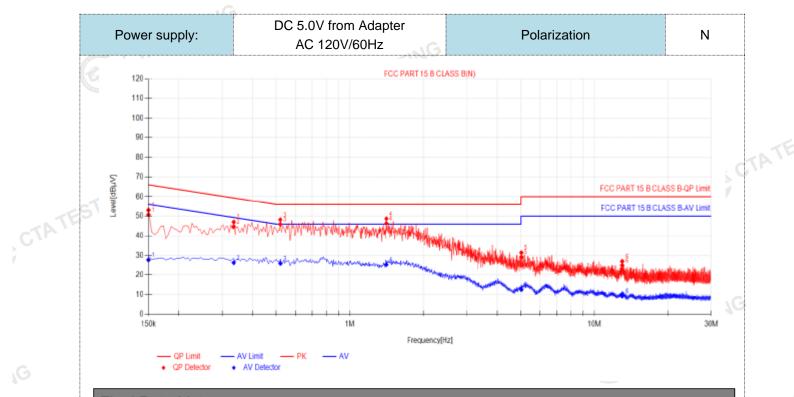


Final Data List

	NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict
	1	0.411	9.89	36.53	46.42	57.63	11.21	15.28	25.17	47.63	22.46	PASS
	2	0.582	10.04	36.50	46.54	56.00	9.46	14.55	24.59	46.00	21.41	PASS
	3	0.7755	9.96	35.74	45.70	56.00	10.30	16.09	26.05	46.00	19.95	PASS
	4	1.8015	9.91	36.15	46.06	56.00	9.94	13.39	23.30	46.00	22.70	PASS
	5	4.0605	9.92	19.41	29.33	56.00	26.67	1.92	11.84	46.00	34.16	PASS
	6	8.169	10.28	14.77	25.05	60.00	34.95	-1.98	8.30	50.00	41.70	PASS
Ν	lote:1)	.QP Value	e (dBµV)=	= QP Rea	ading (dE	3μV)+ Fa	actor (dB))				

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
 - 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- 4). AVMargin(dB) = AV Limit (dB μ V) AV Value (dB μ V) GTA CTATESTING

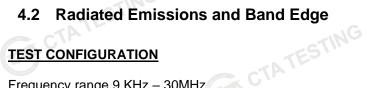
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Final Data List

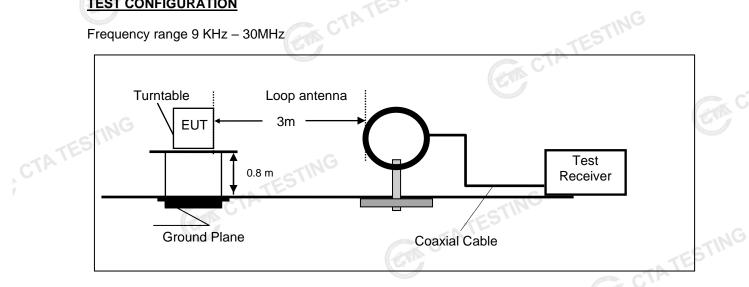
Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict	
0.15	9.98	40.76	50.74	66.00	15.26	17.79	27.77	56.00	28.23	PASS	
0.3345	9.86	34.87	44.73	59.34	14.61	16.49	26.35	49.34	22.99	PASS	
0.519	10.04	35.88	45.92	56.00	10.08	15.98	26.02	46.00	19.98	PASS	
1.41	10.15	36.27	46.42	56.00	9.58	15.21	25.36	46.00	20.64	PASS	
5.019	10.08	19.11	29.19	60.00	30.81	2.52	12.60	50.00	37.40	PASS	
12.9885	10.41	14.63	25.04	60.00	34.96	-1.10	9.31	50.00	40.69	PASS	
Note:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB)											
	[MH2] 0.15 0.3345 0.519 1.41 5.019 12.9885	[MH2] [dB] 0.15 9.98 0.3345 9.86 0.519 10.04 1.41 10.15 5.019 10.08 12.9885 10.41	Freq. Factor Reading(dB [MHz] [dB] Plant 0.15 9.98 40.76 0.3345 9.86 34.87 0.519 10.04 35.88 1.41 10.15 36.27 5.019 10.08 19.11 12.9885 10.41 14.63	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Freq. [MHz] Factor [dB] Reading[dB} µV] Value [dBµV] Limit [dB] Margin [dB] Reading [dB] Value [dBµV] Limit [dB] Margin [dB] Verdiot 0.15 9.98 40.76 50.74 66.00 15.26 17.79 27.77 56.00 28.23 PASS 0.3345 9.88 34.87 44.73 59.34 14.81 16.49 26.35 49.34 22.99 PASS 0.519 10.04 35.88 45.92 56.00 10.08 15.98 26.02 46.00 19.98 PASS 1.41 10.15 36.27 46.42 56.00 9.58 15.21 25.36 46.00 20.64 PASS 5.019 10.08 19.11 29.19 60.00 30.81 2.52 12.60 50.00 37.40 PASS 12.9885 10.41 14.63 25.04 60.00 34.96 -1.10 9.31 50.00 40.89 PASS

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- CTATESTING 4). AVMargin(dB) = AV Limit (dB μ V) - AV Value (dB μ V)

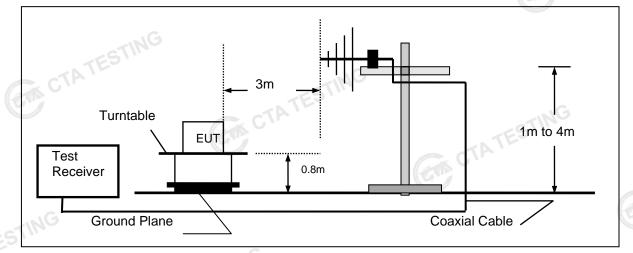


TEST CONFIGURATION

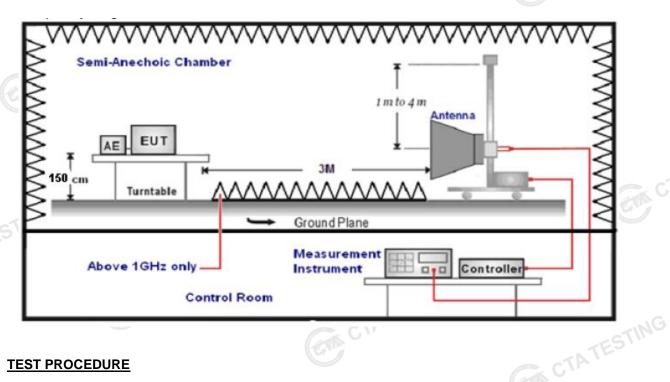
Frequency range 9 KHz – 30MHz



Frequency range 30MHz – 1000MHz



Frequency range above 1GHz-25GHz



TEST PROCEDURE

- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz -1GHz; the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz - 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and
- rotating the turn table from 0°C to 360°C to acquire the highest emissions from EUT. 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- 5. The EUT minimum operation frequency was 32.768KHz and maximum operation frequency was 2480MHz.so radiated emission test frequency band from 9KHz to 25GHz.
- The distance between test antenna and EUT as following table states: 6.

Test Antenna Type	Test Distance	
Active Loop Antenna	3	Acount C
Ultra-Broadband Antenna	3	
Double Ridged Horn Antenna	3	The Past weather the
Horn Anternna	1	
	Active Loop Antenna Ultra-Broadband Antenna Double Ridged Horn Antenna	Active Loop Antenna3Ultra-Broadband Antenna3Double Ridged Horn Antenna3

Setting test receiver/spectrum as following table states: 7.

Test Frequency range	Test Receiver/Spectrum Setting	Detector	
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP	
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP	
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP	
and the second se	Peak Value: RBW=1MHz/VBW=3MHz,	TING	
1GHz-40GHz	Sweep time=Auto	Peak	
IGHZ-40GHZ	Average Value: RBW=1MHz/VBW=10Hz,	reak	
	Sweep time=Auto		

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS = RA + AF + CL - AG

le calculation is as follows:	
RA + AF + CL - AG	
Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	
	ATA CTA
Shenzhen CTA Testin	na Technoloav Co., Ltd.

Transd=AF +CL-AG

RADIATION LIMIT

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
1.705-30	3	20log(30)+ 40log(30/3)	30
30-88	3	40.05	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500

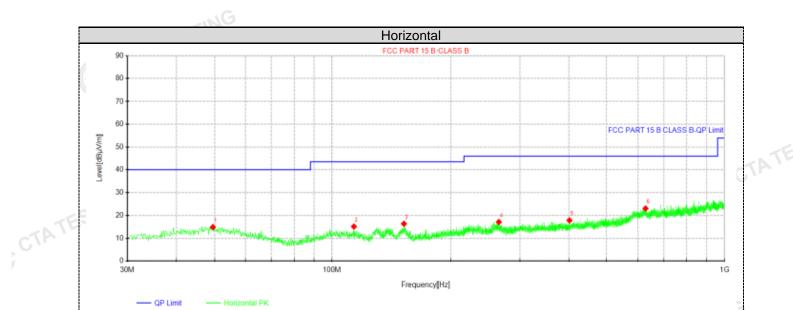
TEST RESULTS

Remark:

- 1. This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X position.
- 2. BLE 1Mpbs were tested at Low, Middle, and High channel and recorded worst mode at BLE 1Mpbs.
- Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found 3. except system noise floor in 9 KHz to 30MHz and not recorded in this report. CTA TESTING

For 30MHz-1GHz

COM CTATE



QP Detector

TING

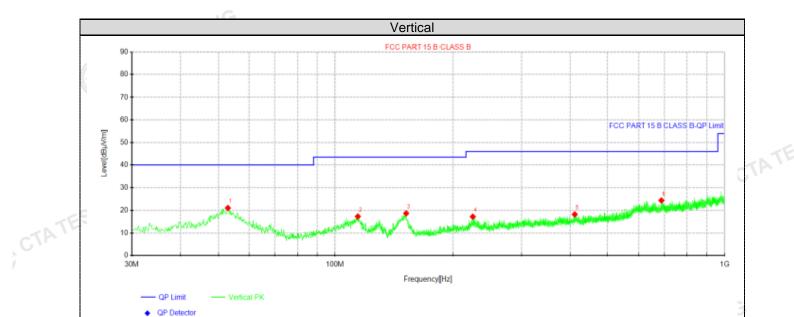
CTATES

	Suspected Data List										
	NO.	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Polarity	
	NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Tolanty	
	1	49.5212	26.26	14.79	-11.47	40.00	25.21	100	103	Horizontal	
	2	113.541	28.96	15.03	-13.93	43.50	28.47	100	197	Horizontal	
	3	152.705	32.37	16.27	-16.10	43.50	27.23	100	33	Horizontal	
	4	264.861	29.34	17.03	-12.31	46.00	28.97	100	360	Horizontal	
	5	401.267	28.24	17.77	-10.47	46.00	28.23	100	91	Horizontal	
	6	628.126	28.24	23.03	-5.21	46.00	22.97	100	81	Horizontal	
TEST											
Ν	Note:1).Level (dB μ V/m)= Reading (dB μ V)+ Factor (dB/m)										

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB μ V/m) Level (dB μ V/m)

CTATESTING

CTATE



Suspected Data List

Jus	Suspected Data List										
NO	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Polarity		
NO	. [MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Folanty		
1	52.9162	32.72	21.00	-11.72	40.00	19.00	100	1	Vertical		
2	114.268	31.20	17.22	-13.98	43.50	26.28	100	304	Vertical		
3	152.462	34.69	18.60	-16.09	43.50	24.90	100	327	Vertical		
4	224.97	30.13	17.13	-13.00	46.00	28.87	100	177	Vertical		
5	411.088	28.53	18.16	-10.37	46.00	27.84	100	247	Vertical		
6	687.538	29.62	24.38	-5.24	46.00	21.62	100	0	Vertical		

Note:1).Level (dB μ V/m)= Reading (dB μ V)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dBµV/m) - Level (dBµV/m)

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For 1GHz to 25GHz

	T	N		GFSK (abo	ve 1GHz)				
Freque	Frequency(MHz):		2402		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4804.00	62.16	PK	74	11.84	66.43	32.33	5.12	41.72	-4.27
4804.00	45.39	AV	54	8.61	49.66	32.33	5.12	41.72	-4.27
7206.00	52.25	PK	74	21.75	52.77	36.6	6.49	43.61	-0.52
7206.00	42.27	AV	54	11.73	42.79	36.6	6.49	43.61	-0.52

Frequency(MHz):		2402		Polarity:		VERTICAL			
Frequency (MHz)	Emis Lev (dBu)	/el	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4804.00	60.63	PK	74	13.37	64.90	32.33	5.12	41.72	-4.27
4804.00	43.26	AV	54	10.74	47.53	32.33	5.12	41.72	-4.27
7206.00	49.87	PK	74	24.13	50.39	36.6	6.49	43.61	-0.52
7206.00	40.35	AV	54	13.65	40.87	36.6	6.49	43.61	-0.52
				G	1			TE	

Frequency(MHz):		2440		Polarity:		HORIZONTAL			
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4880.00	61.50	PK	74	12.50	65.38	32.6	5.34	41.82	-3.88
4880.00	44.11	AV	54	9.89	47.99	32.6	5.34	41.82	-3.88
7320.00	53.95	PK	74	20.05	54.06	36.8	6.81	43.72	-0.11
7320.00	43.34	AV	54	10.66	43.45	36.8	6.81	43.72	-0.11
CIA'					-ING				•

Frequency(MHz):		2440		Polarity:		VERTICAL			
Frequency (MHz)	Emis Lev (dBu)		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4880.00	59.79	PK	74	14.21	63.67	32.6	5.34	41.82	-3.88
4880.00	42.49	AV	54	11.51	46.37	32.6	5.34	41.82	-3.88
7320.00	51.21	PK	74	22.79	51.32	36.8	6.81	43.72	-0.11
7320.00	41.56	AV	54	12.44	41.67	36.8	6.81	43.72	-0.11
			STIN						

Frequency(MHz):		2480		Polarity:		HORIZONTAL			
Frequency (MHz)	Emis Le [.] (dBu		Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	60.88	PK	74	13.12	63.96	32.73	5.66	41.47	-3.08
4960.00	44.21	AV	54	9.79	47.29	32.73	5.66	41.47	-3.08
7440.00	52.79	PK	74	21.21	52.34	37.04	7.25	43.84	0.45
7440.00	42.43	PK	54	11.57	41.98	37.04	7.25	43.84	0.45

Freque	Frequency(MHz):		2480		Polarity:		VERTICAL		
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	G Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
4960.00	59.31	PK	74	14.69	62.39	32.73	5.66	o 41.47	-3.08
4960.00	42.66	AV	54	11.34	45.74	32.73	5.66	41.47	-3.08
7440.00	50.92	PK	74	23.08	50.47	37.04	7.25	43.84	0.45
7440.00	40.24	PK	54	13.76	39.79	37.04	7.25	43.84	0.45
REMARKS	:				6	Contraction of the second			CTP
			Shenzhen	CTA Testing	Technology	Co., Ltd.			

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

Results of Band Edges Test (Radiated)

Freque	ncy(MHz)	:	240	GFS 02		arity:	HORIZONTAL			
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
2390.00	62.26	PK	74	11.74	72.68	27.42	4.31	42.15	-10.42	
2390.00	42.93	AV	54	11.07	53.35	27.42	4.31	42.15	-10.42	
Freque	Frequency(MHz):		240	2402 Polarity:		VERTICAL				
Frequency (MHz)	Emis Lev (dBu ^v	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
2390.00	60.12	PK	74	13.88	70.54	27.42	4.31	42.15	-10.42	
2390.00	41.13	AV	54	12.87	51.55	27.42	4.31	42.15	-10.42	
Freque	Frequency(MHz):		24	2480 P		olarity: HORIZO		ORIZONTA	TAL	
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)	
	61.70	ΡK	74	12.30	71.81	27.7	4.47	42.28	-10.11	
2483.50	01.70			11.23	52.88	27.7	4.47	42.28	-10.11	
2483.50 2483.50	42.77	AV	54	11.20	52.00	Polarity:				
2483.50			54 248			arity:		VERTICAL		
2483.50	42.77	: sion vel	1			Antenna Factor (dB/m)	Cable Factor (dB)	VERTICAL Pre- amplifier (dB)	Correction Factor (dB/m)	
2483.50 Freque Frequency	42.77 ncy(MHz) Emis Lev	: sion vel	244 Limit	30 Margin	Pola Raw Value	Antenna Factor	Factor	Pre- amplifier	Correction Factor	

4. -- Mean the PK detector measured value is below average limit.

5. The other emission levels were very low against the limit.

Maximum Peak Output Power 4.3

Limit

The Maximum Peak Output Power Measurement is 30dBm.

Test Procedure

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the power sensor.

Test Configuration



Test Results

est Results				ATESI
Туре	Channel	Output power (dBm)	Limit (dBm)	Result
	00	-0.51		
GFSK 1Mbps	19	-0.84	30.00	Pass
CTA	39	-0.90		
Note: 1.The test res		TESI	CTATESTING	

4.4 **Power Spectral Density**

Limit C

For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission.

Test Procedure

- 1. Use this procedure when the maximum peak conducted output power in the fundamental emission is used to demonstrate compliance.
- 2. Set the RBW \geq 3 kHz.
- 3. Set the VBW \geq 3× RBW.
- CTATESTING 4. Set the span to 1.5 times the DTS channel bandwidth.
- 5. Detector = peak.
- 6. Sweep time = auto couple.
- 7. Trace mode = max hold.
- 8. Allow trace to fully stabilize.
- 9. Use the peak marker function to determine the maximum power level.
- 10. If measured value exceeds limit, reduce RBW (no less than 3 kHz) and repeat.
- 11. The resulting peak PSD level must be 8dBm.

Test Configuration

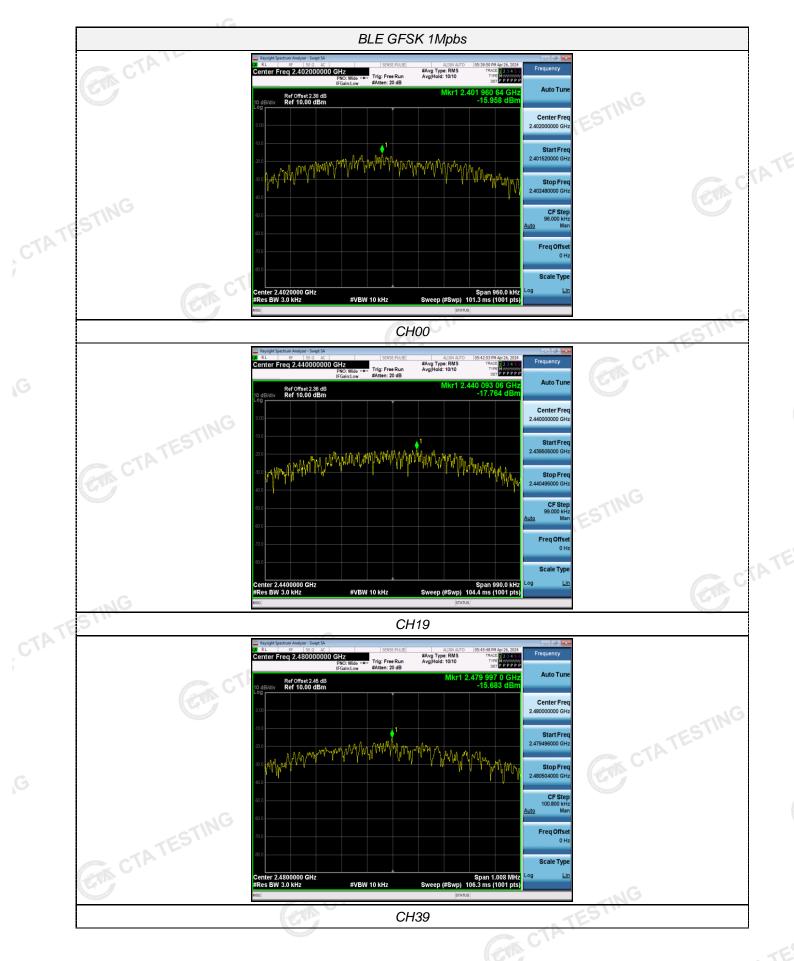


Test Results

T		Power Spectral Density		
Туре	Channel	(dBm/3KHz)	Limit (dBm/3KHz)	Result
	00	-15.96		
GFSK 1Mbps	19	-17.76	8.00	Pass
	39	-15.68	NG	
Test plot as foll	GV	-15.68	TING	



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4.5 6dB Bandwidth

Limit

ESTING For digital modulation systems, the minimum 6 dB bandwidth shall be at least 500 kHz

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 100 KHz RBW and 300 KHz VBW. The 6dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 6dB.

Test Configuration



Test Results

Test Results	-	ANALYZ	FR	CTATESTING
Туре	Channel	6dB Bandwidth (MHz)	Limit (KHz)	Result
GTINC	00	0.640		
GFSK 1Mbps	19	0.660	≥500	Pass
CIL	39	0.672		
Test plot as follows:	CAN C	TATES	CTA TESTIN	G

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Out-of-band Emissions 4.6

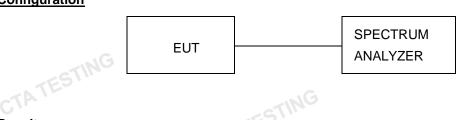
Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

Test Procedure

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector , and max hold. Measurements utilizing these setting are GTA CTATESTING made of the in-band reference level, bandedge and out-of-band emissions.

Test Configuration

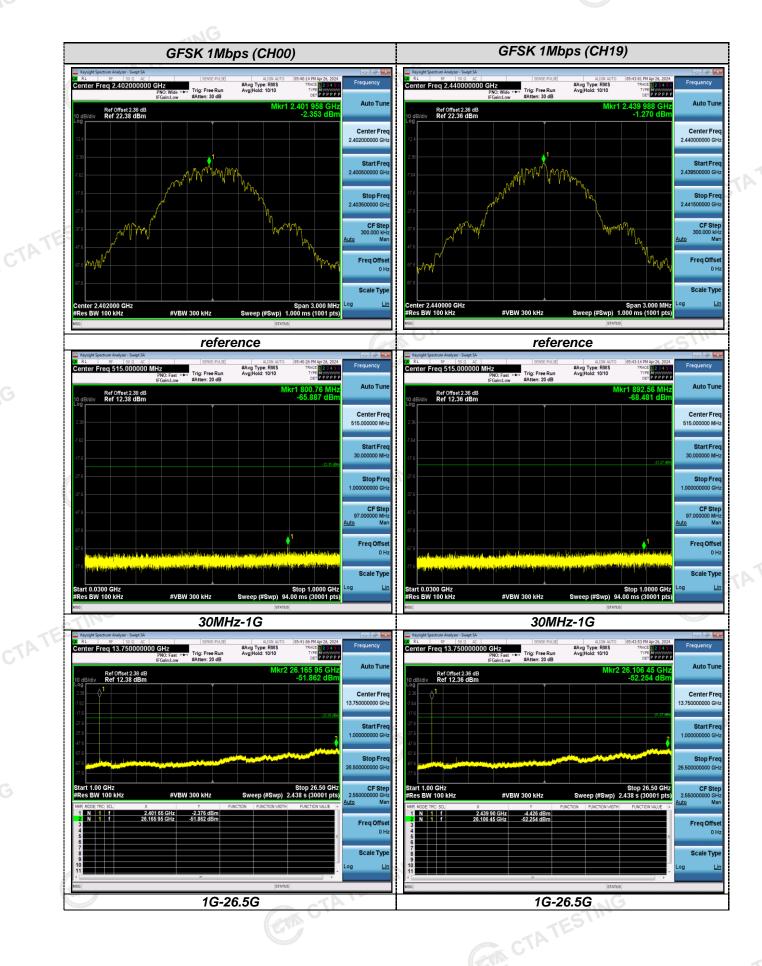


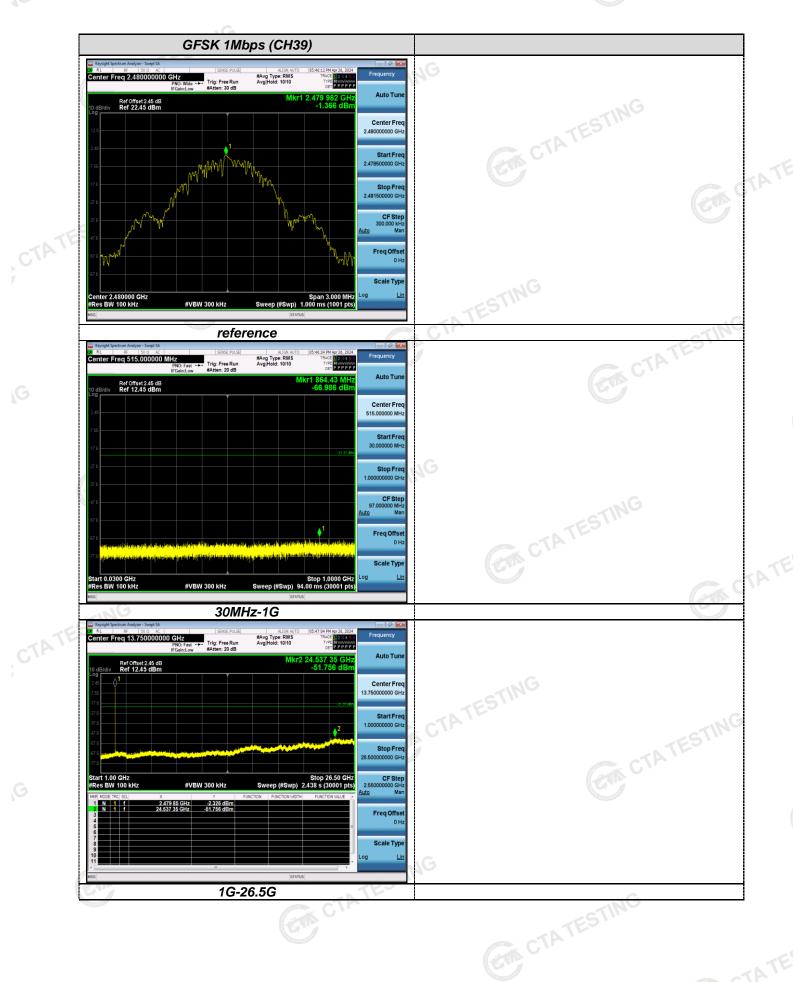
Test Results

Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage **GIA CTATE** measurement data.

Test plot as follows:

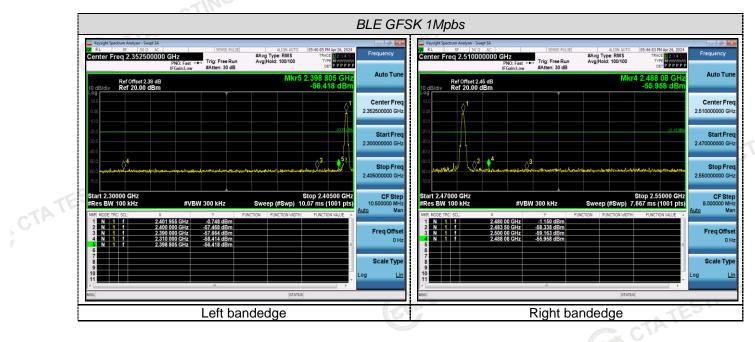
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Band-edge Measurements for RF Conducted Emissions:



4.7 Antenna Requirement

Standard Applicable

For intentional device, according to FCC 47 CFR Section 15.203:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited

FCC CFR Title 47 Part 15 Subpart C Section 15.247(c) (1) (I):

(i) Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6dBi.

Antenna Connected Construction

The gain of antenna was 0.68 dBi.

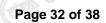
Remark: The antenna gain is provided by the customer , if the data provided by the customer is not accurate, Shenzhen CTA Testing Technology Co., Ltd. does not assume any responsibility.

5 Test Setup Photos of the EUT



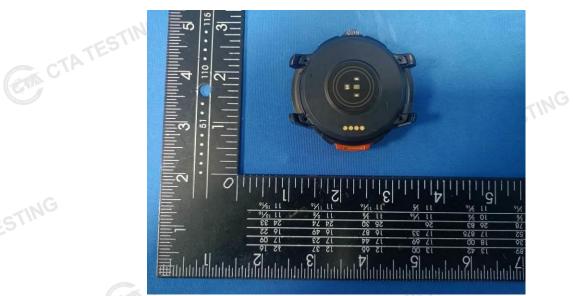


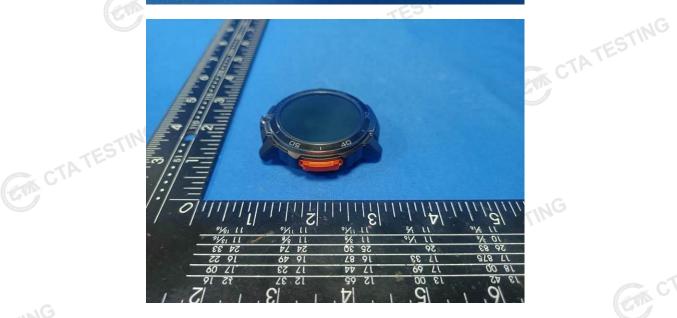






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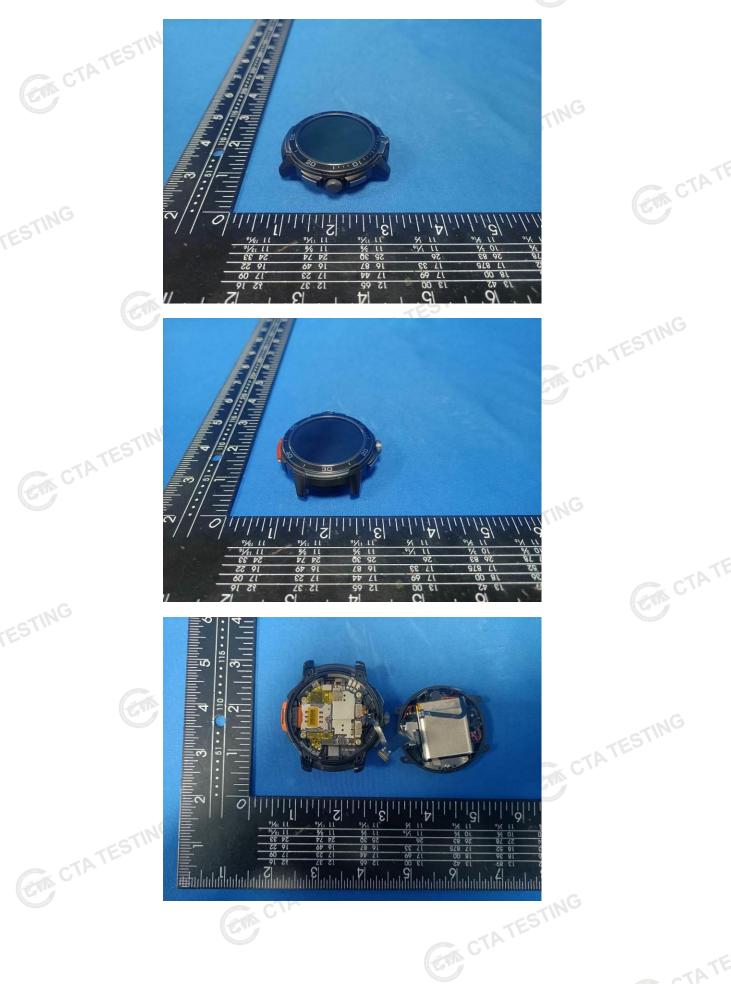




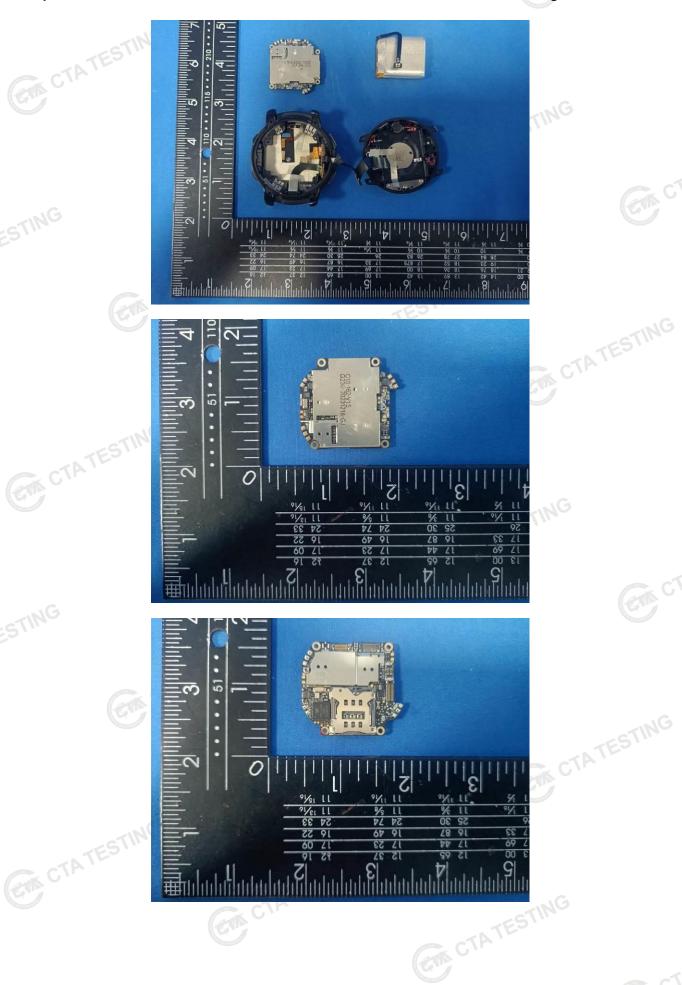


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